128K x 8 EEPROM
Radiation Tolerant

AVAILABLE AS MILITARY SPECIFICATIONS
- SMD 5962-38267
- MIL-PRF-38535

FEATURES
- High speed: 150, 200, and 250ns
- Data Retention: 10 Years
- Low power dissipation, active current (20mW/MHz (TYP)), standby current (100µW(MAX))
- Single +5V (±10%) power supply
- Data Polling and Ready/Busy Signals
- Erase/Write Endurance (10,000 cycles in a page mode)
- Software Data protection Algorithm
- Data Protection Circuitry during power on/off
- Hardware Data Protection with RES pin
- Automatic Programming:
  Automatic Page Write: 10ms (MAX)
  128 Byte page size

PIN ASSIGNMENT
(Top View)

32-Pin CFP (F & SF), 32-Pin CSOJ (DCJ)

RDY/BUSY\	1	32	Vcc
A16	2	31	A15
A14	3	30	RES\
A12	4	29	WE\
A7	5	28	A13
A6	6	27	A8
A5	7	26	A9
A4	8	25	A11
A3	9	24	OE\
A2	10	23	A10
A1	11	22	CE\
A0	12	21	I/O 7
I/O 0	13	20	I/O 6
I/O 1	14	19	I/O 5
I/O 2	15	18	I/O 4
Vss	16	17	I/O 3

OPTIONS — MARKINGS
- Timing
  - 150ns access -15
  - 200ns access -20
  - 250ns access -25
- Packages
  - Ceramic Flat Pack F No. 306
  - Radiation Shielded Ceramic FP* SF No. 305
  - Ceramic SOJ DCJ No. 508
- Operating Temperature Ranges
  - -Military (-55°C to +125°C) XT
  - -Industrial (-40°C to +85°C) IT
  - -Full Military Processing (-55°C to +125°C) 883C

***NOTE:** *Package lid is connected to ground (Vss). 2-sided shielding provided via a Tungsten lid and a Tungsten slug on the underside of package. 6.5X typ. TID boost due to shielding. (Geostationary orbit) Proven typ. total dose 40K to 100K RADS. Contact factory for more information. Micross can perform TID lot testing.*

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www.micross.com

GENERAL DESCRIPTION
The AS58C1001 is a 1 Megabit CMOS Electrically Erasable Programmable Read Only Memory (EEPROM) organized as 131, 072 x 8 bits. The AS58C1001 is capable or in system electrical Byte and Page reprogrammability.

The AS58C1001 achieves high speed access, low power consumption, and a high level of reliability by employing advanced MNOS memory technology and CMOS process and circuitry technology and CMOS process and circuitry technology.

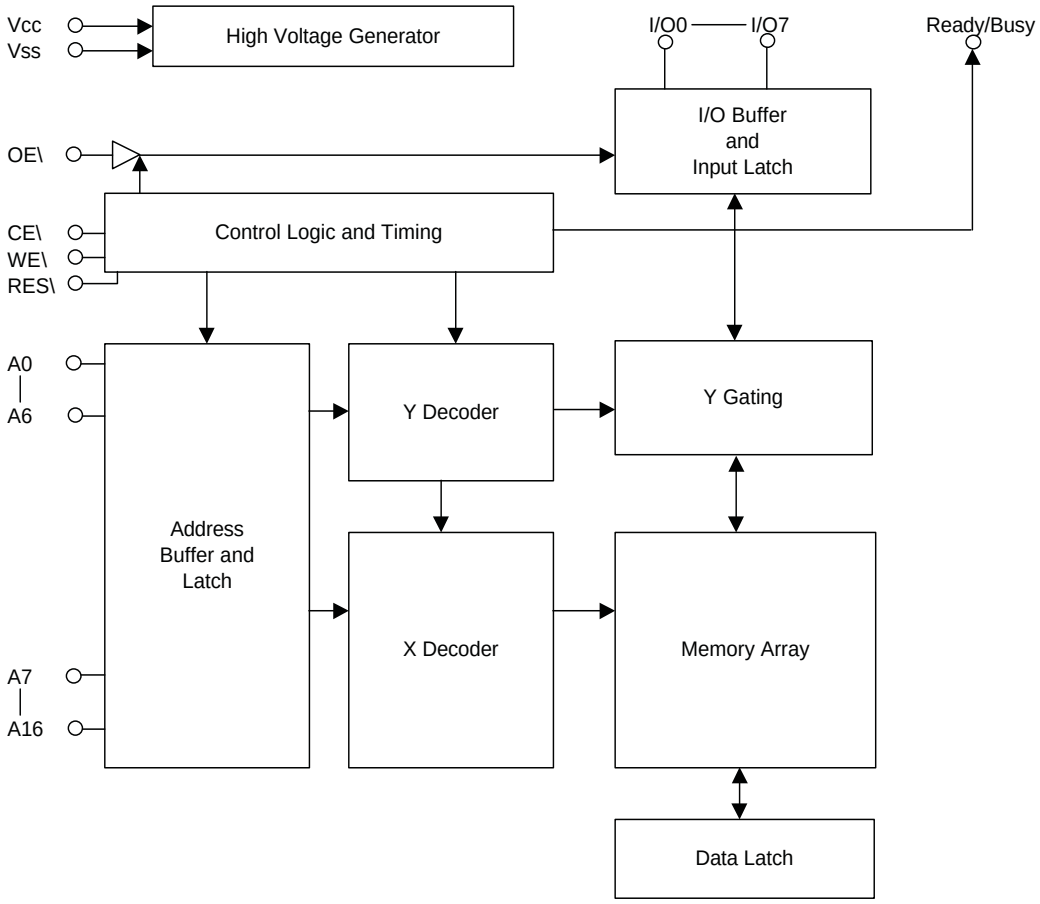
This device has a 128-Byte Page Programming function to make its erase and write operations faster. The AS58C1001 features Data Polling and a Ready/Busy signal to indicate completion of erase and programming operations.

This EEPROM provides several levels of data protection. Hardware data protection is provided with the RES pin, in addition to noise protection on the WE signal and write inhibit during power on and off. Software data protection is implemented using JEDEC Optional Standard algorithm.

The AS58C1001 is designed for high reliability in the most demanding applications. Data retention is specified for 10 years and erase/write endurance is guaranteed to a minimum of 10,000 cycles in the Page Mode.

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FUNCTIONAL BLOCK DIAGRAM



MODE SELECTION

MODE	CE\	OE\	WE\	RES\	RDY/BUSY\[1]	I/O
READ	V_{IL}	V_{IL}	V_{IH}	V_H	High-Z	D_{OUT}
STANDBY	V_{IH}	X	X	X	High-Z	High-Z
WRITE	V_{IL}	V_{IH}	V_{IL}	V_H	High-Z to V_{OL}	D_{IN}
DESELECT	V_{IL}	V_{IH}	V_{IH}	V_H	High-Z	High-Z
WRITE INHIBIT	X	X	V_{IH}	X	---	---
	X	V_{IL}	X	X	---	---
DATA POLLING	V_{IL}	V_{IL}	V_{IH}	V_H	V_{OL}	Data Out (I/O7)
PROGRAM	X	X	X	V_{IL}	High-Z	High-Z

FUNCTIONAL DESCRIPTION

AUTOMATIC PAGE WRITE

The Page Write feature allows 1 to 128 Bytes of data to be written into the EEPROM in a single cycle and allows the undefined data within 128 Bytes to be written corresponding to the undefined address (A_0 to A_6). Loading the first Byte of data, the data load window of 30µs opens for the second. In the same manner each additional Byte of data can be loaded within 30µs. In case CE\ and WE\ are kept high for 100µs after data input, the EEPROM enters erase and write automatically and only the input data can be written into the EEPROM. In Page mode the data can be written and accessed 10^4 times per page, and in Byte mode 10^3 times per Byte.

DATA\ POLLING

Data\ Polling allows the status of the EEPROM to be determined. If the EEPROM is set to Read mode during a Write cycle, and inversion of the last Byte of data to be loaded outputs from I/O, to indicate that the EEPROM is performing a Write operation.

WRITE PROTECTION

(1) Noise protection: Noise on a write cycle will not act as a trigger with a WE\ pulse of less than 20ns.
(2) Write inhibit: Holding OE\ low, WE\ high or CE\ high, inhibits a write cycle during power on/off.

WE\ AND CE\ PIN OPERATION

During a write cycle, addresses are latched by the falling edge of WE\ or CE\, and data is latched by the rising edge of WE\ or CE\.

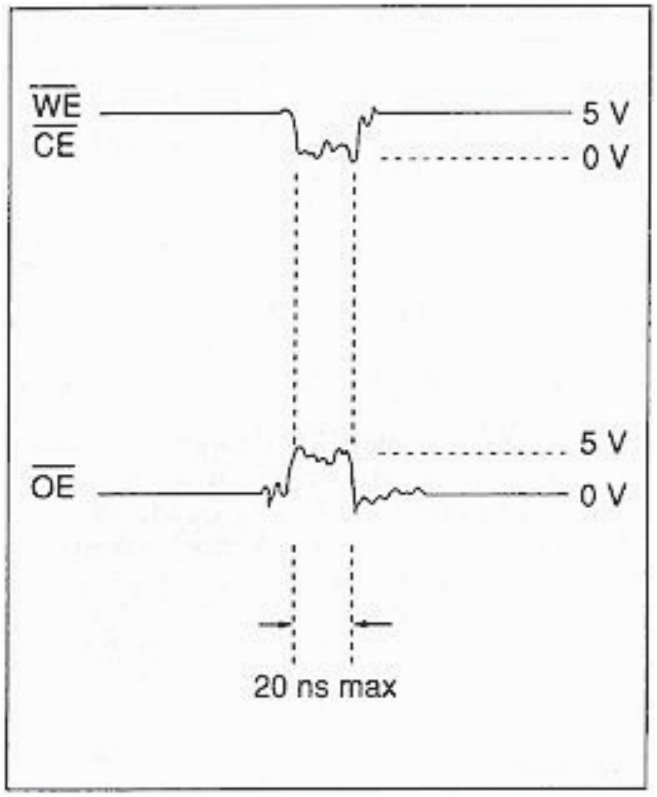
WRITE/ERASE ENDURANCE AND DATA RETENTION

The endurance with page programming is 10^4 cycles (1% cumulative failure rate) and the data retention time is more than 10 years when a device is programmed less than 10^4 cycles.

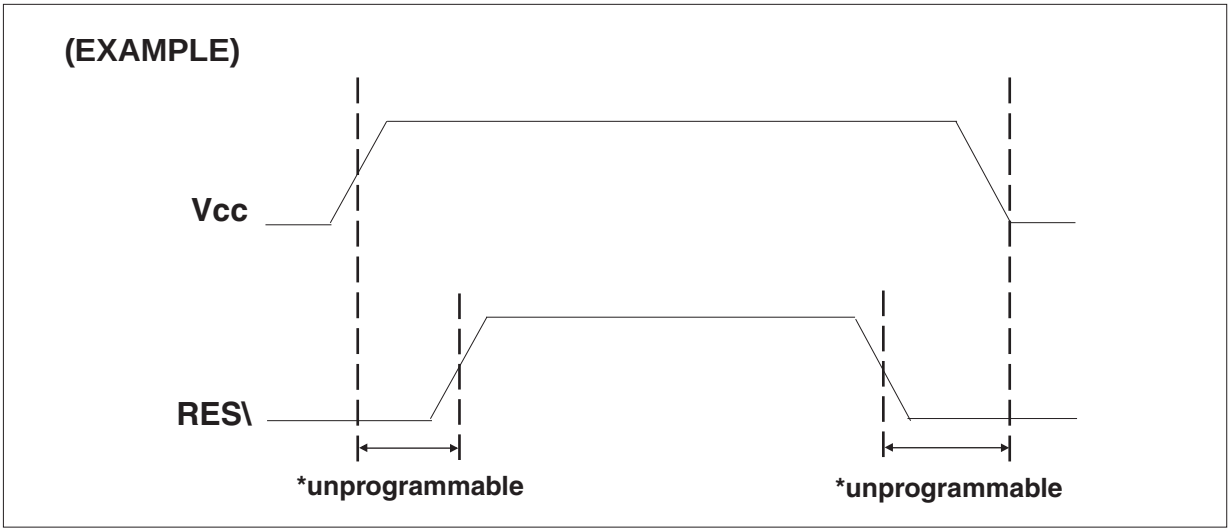
DATA PROTECTION

To protect the data during operation and power on/off, the AS58C1001 has:

1. Data protection against Noise on Control Pins (CE\, OE\, WE\) during Operation. During readout or standby, noise on the control pins may act as a trigger and turn the EEPROM to programming mode by mistake. To prevent this phenomenon, the AS58C1001 has a noise cancellation function that cuts noise if its width is 20ns or less in programming mode. Be careful not to allow noise of a width of more than 20ns on the control pins.



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FUNCTIONAL DESCRIPTION (continued)

DATA PROTECTION (continued)

2. Data protection at Vcc on/off.

When RES\ is low, the EEPROM cannot be erased and programmed. Therefore, data can be protected by keeping RES\ low when Vcc is switched. RES\ should be high during programming because it does not provide a latch function. When Vcc is turned on or off, noise on the control pins generated by external circuits (CPU, etc.) may turn the EEPROM to programming mode by mistake. To prevent this unintentional programming, the EEPROM must be kept in an unprogrammable, standby or readout state by using a CPU reset signal to RES\ pin.

In addition, when RES\ is kept high at Vcc on/off timing, the input level of control pins (CE\, OE\, WE\) must be held as CE\=Vcc or OE\=LOW or WE\=Vcc level.

3. Software Data Protection

To protect against unintentional programming caused by noise generated by external circuits, AS58C1001 has a Software data protection function. To initate Software data protection mode, 3 bytes of data must be input, followed by a dummy write cycle of any address and any data byte. This exact sequence switches the device into protection mode.

Write Address	Write Data (Normal Data Input)
5555	AA
↓	↓
2AAA	55
↓	↓
5555	A0

The Software data protection mode can be cancelled by inputting the following 6 Bytes. This changes the AS58C1001 to the Non-Protection mode, for normal operation.

Address	Data
5555	AA
↓	↓
2AAA	55
↓	↓
5555	80
↓	↓
5555	AA
↓	↓
2AAA	55
↓	↓
5555	20

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ABSOLUTE MAXIMUM RATINGS*

Voltage on Vcc Supply Relative to Vss.....-0.5V to +7.0V[1]
Voltage on any pin Relative to Vss.....-0.6V to +7.0V[1]
Storage Temperature .....-65°C to +150°C
Operating Temperature Range.....-55°C to +125°C
Soldering Temperature Range.....260°C
Maximum Junction Temperature**.....+150°C
Power Dissipation.....1.0W

*Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operation section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
** Junction temperature depends upon package type, cycle time, loading, ambient temperature and airflow.

ELECTRICAL CHARACTERISTICS AND RECOMMENDED DC OPERATING CONDITIONS

($-55^oC \leq T_A \leq 125^oC$; Vcc = 5V ±10%)

PARAMETER	CONDITION	SYMBOL	MIN	MAX	UNITS	NOTES
Input High (Logic 1) Voltage		V_{IH}	2.2	V_{CC} + 0.3V	V	9
Input Low (Logic 0) Voltage[3]		V_{IL}	-0.3	0.8	V	2
Input Voltage (RES\ Pin)		V_H	Vcc-0.5	V_{CC} +1.0	V	
Input Leakage Current[4]	$OV \leq V_{IN} \leq Vcc$	I_{LI}	-2	2	µA	4
Output Leakage Current	Output(s) disabled, $OV \leq V_{OUT} \leq Vcc$	I_{LO}	-2	2	µA	
Output High Voltage	I_{OH} = -400 µA	V_{OH}	2.4		V	
Output Low Voltage	I_{OL} = 2.1 mA	V_{OL}		0.4	V	

PARAMETER	CONDITIONS	SYM	MAX -15	MAX -20	MAX -25	UNITS	NOTES
Power Supply Current: Operating	I_{OUT}=OmA, Vcc = 5.5V Cycle=1µS, Duty=100%	I_{CC3}	20	20	20	mA	
	I_{OUT}=OmA, Vcc = 5.5V Cycle=MIN, Duty=100%		65	55	50		
Power Supply Current: Standby	CE\=Vcc, Vcc = 5.5V	I_{CC1}	350	350	350	µA	
	CE\=V_{IH}, Vcc = 5.5V	I_{CC2}	3	3	3	mA	

CAPACITANCE

PARAMETER	CONDITIONS	SYMBOL	MAX	UNITS	NOTES
Input Capacitance	$T_A = 25^oC$, f = 1MHz V_{IN} = 0	C_{IN}	6	pF	
Output Capactiance		Co	12	pF	

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AC ELECTRICAL CHARACTERISTICS FOR READ OPERATION

($-55^oC \leq T_C \leq 125^oC$; Vcc = 5V ±10%)

Test Conditions

- Input Pulse Levels: 0.0V to 3.0V
- Input rise and fall times: ≤ 20ns
- Output Load: 1 TTL Gate +100pF (including scope and jig)
- Reference levels for measuring timing: 1.5V, 1.5V

ITEM DESCRIPTION	TEST CONDITION	SYMBOL	-15		-20		-25		UNITS
			MIN	MAX	MIN	MAX	MIN	MAX	
Address Access Time	CE\=OE\=V_{IL} WE\=V_{IH}	t_{ACC}	---	150	---	200	---	250	ns
Chip Enable Access Time	OE\=V_{IL} WE\=V_{IH}	t_{CE}	—	150	—	200	—	250	ns
Output Enable Acess Time	CE\=V_{IL} WE\=V_{IH}	t_{OE}	10	75	10	75	10	75	ns
Output Hold to Address Change	CE\=OE\=V_{IL} WE\=V_{IH}	t_{OH}	0	—	0	---	0	—	ns
Output Disable to High-Z	CE\=V_{IL} WE\=V_{IH}	t_{DF}	0	50	0	50	0	50	ns
	CE\=OE\=V_{IL} WE\=V_{IH}	t_{DFR}	0	350	0	350	0	350	ns
RES\ to Output Delay	CE\=OE\=V_{IL} WE\=V_{IH}	t_{RR}	0	450	0	450	0	450	ns

AC ELECTRICAL CHARACTERISTICS FOR SOFTWARE DATA PROTECTION CYCLE OPERATION

PARAMETER	SYMBOL	MIN	MAX	UNITS
Byte Load Cycle Time	t_{BLC}	0.55	30	µS
Write Cycle Time	t_{WC}	10	---	mS

AC ELECTRICAL CHARACTERISTICS FOR DATA\ POLLING OPERATION

PARAMETER	SYMBOL	MIN	MAX	UNITS
Output Enable Hold Time	t_{OEH}	0	---	ns
Output Enable to Write Setup Time	t_{OES}	0	---	ns
Write Start Time	t_{DW}	150	---	ns
Write Cycle Time	t_{WC}	---	10	ms

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AC ELECTRICAL CHARACTERISTICS FOR PAGE ERASE AND PAGE WRITE OPERATIONS

PARAMETER	SYMBOL	MIN	MAX	UNITS
Address Setup Time	t_{AS}	0	---	ns
Write Enable to Write Setup Time	t_{WS} [8]	0	---	ns
Chip Enable to Write Setup Time	t_{CS} [7]	0	---	ns
Write Pulse Width	t_{WP} [7]	250	---	ns
	t_{CW} [9]	250	---	ns
Address Hold Time	t_{AH}	150	---	ns
Data Setup Time	t_{DS}	100	---	ns
Data Hold Time	t_{DH}	10	---	ns
Write Enable Hold Time	t_{WH} [8]	0	---	ns
Chip Enable Hold Time	t_{CH} [7]	0	---	ns
Out Enable to Write Setup Time	t_{OES}	0	---	ns
Output Enable Hold Time	t_{OEH}	0	---	ns
Data Latch Time	t_{DL}	200	---	ns
Write Cycle Time	t_{WC}	10	---	ms
Byte Load Window	t_{BL}	100	---	µs
Byte Load Cycle	t_{BLC}	0.55	30	µs
Time to Device Busy	t_{DB}	120	---	ns
RES\ to Write Setup Time	t_{RP}	100	---	µs
Vcc to RES\ Setup Time	t_{RES} [11]	1	---	µs

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AC ELECTRICAL CHARACTERISTICS FOR BYTE ERASE AND BYTE WRITE OPERATIONS

PARAMETER	SYMBOL	MIN	MAX	UNITS
Address Setup Time	t_{AS}	0	---	ns
Chip Enable to Write Setup Time	t_{CS} [7]	0	---	ns
Write Pulse Width	t_{CW} [8]	250	---	ns
	t_{WP} [7]	250	---	ns
Address Hold Time	t_{AH}	150	---	ns
Data Setup Time	t_{DS}	100	---	ns
Data Hold Time	t_{DH}	10	---	ns
Chip Enable Hold Time	t_{CH} [7]	0	---	ns
Out Enable to Write Setup Time	t_{OES}	0	---	ns
Output Enable Hold Time	t_{OEH}	0	---	ns
Write Cycle Time	t_{WC}	10	---	ms
Byte Load Window	t_{BL}	100	---	µs
Time to Device Busy	t_{DB}	120	---	ns
RES\ to Write Setup Time	t_{RP}	100	---	µs
Vcc to RES\ Setup Time	t_{RES} [10]	1	---	µs

AC TEST CONDITIONS

Input Pulse Levels	0V to 3V
Input Rise and Fall Times	≤20ns
Input Timing Reference Level	1.5V
Output Reference Level	1.5V
Output Load	See Figure 1

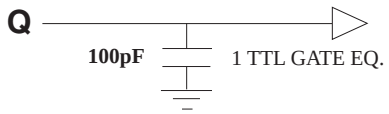
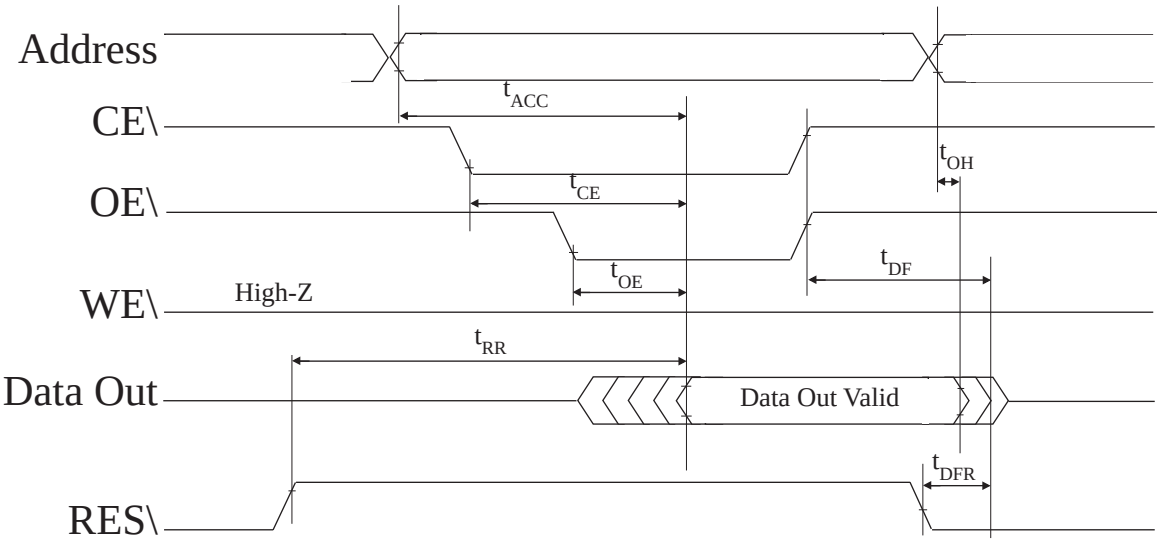


Figure 1
OUTPUT LOAD EQUIVALENT

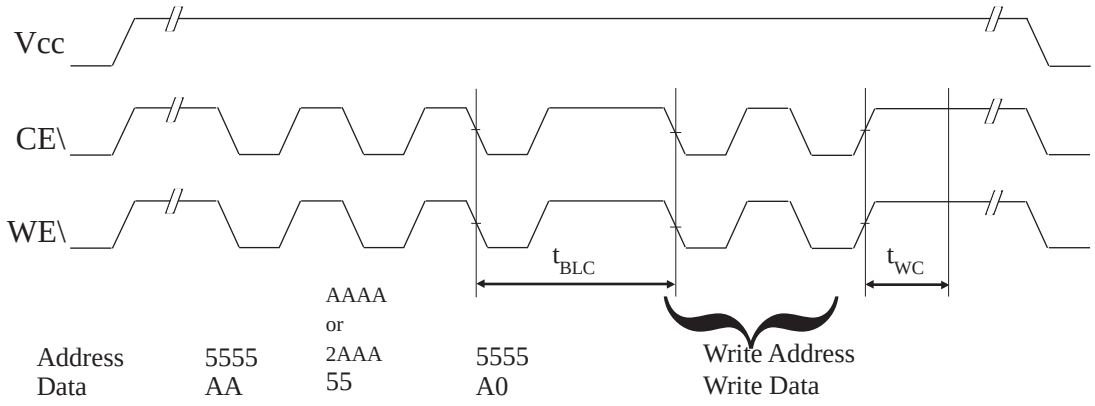
NOTES:
1. Relative to Vss
2. V_{IN} min = -3.0V for pulse widths ≤50ns
3. V_{IL} min = -1.0V for pulse widths ≤50ns
4. I_{IL} on RES\ = 100ua MAX
5. t_{OF} is defined as the time at which E the output becomes and open circuit and data is no longer driven.
6. Use this device in longer cycle than this value
7. WE\ controlled operation
8. CE\ controlled operation
9. RES\ pin V_{IH} is V_H
10. Reference only, not tested

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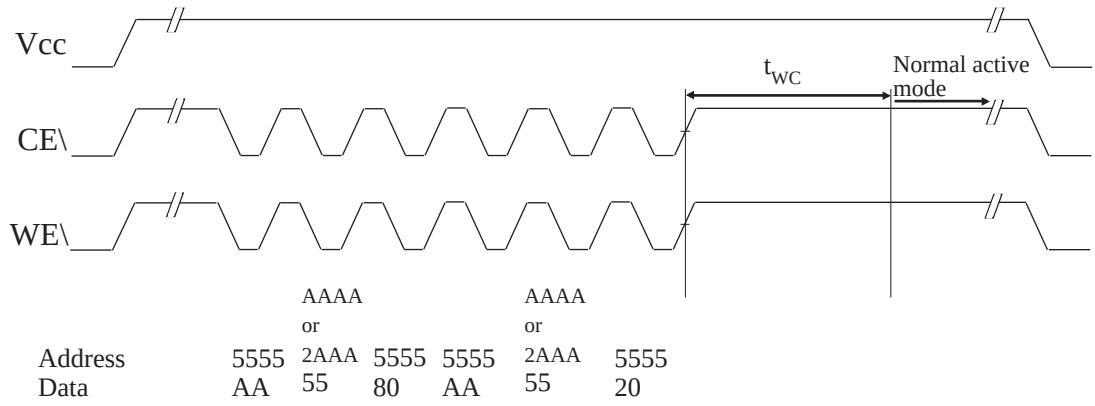
READ TIMING WAVEFORM



SOFTWARE DATA PROTECTION TIMING WAVEFORM (protection mode)

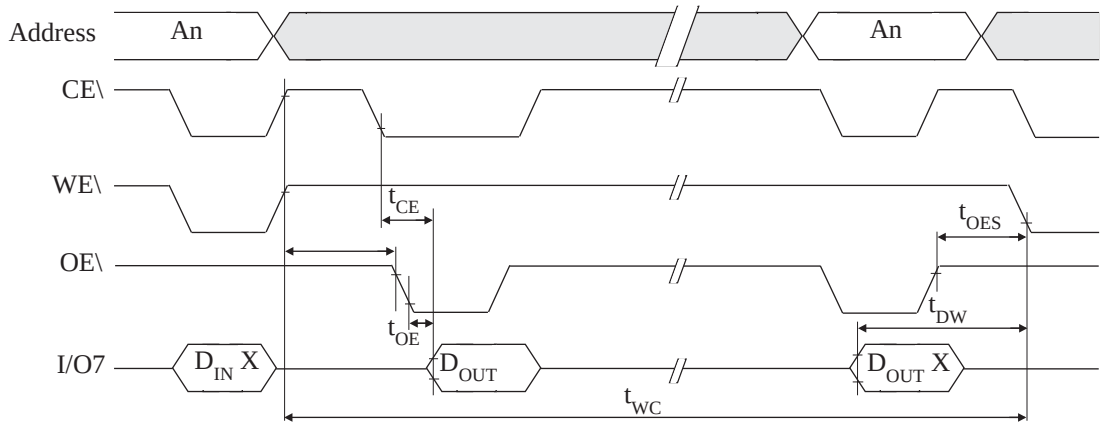


SOFTWARE DATA PROTECTION TIMING WAVEFORM (non-protection mode)

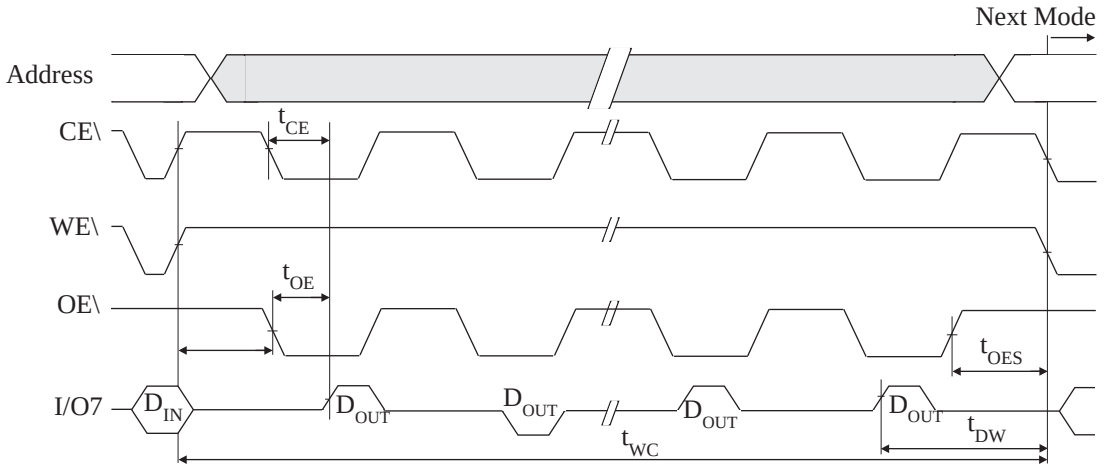


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DATA\ POLLING TIMING WAVEFORM



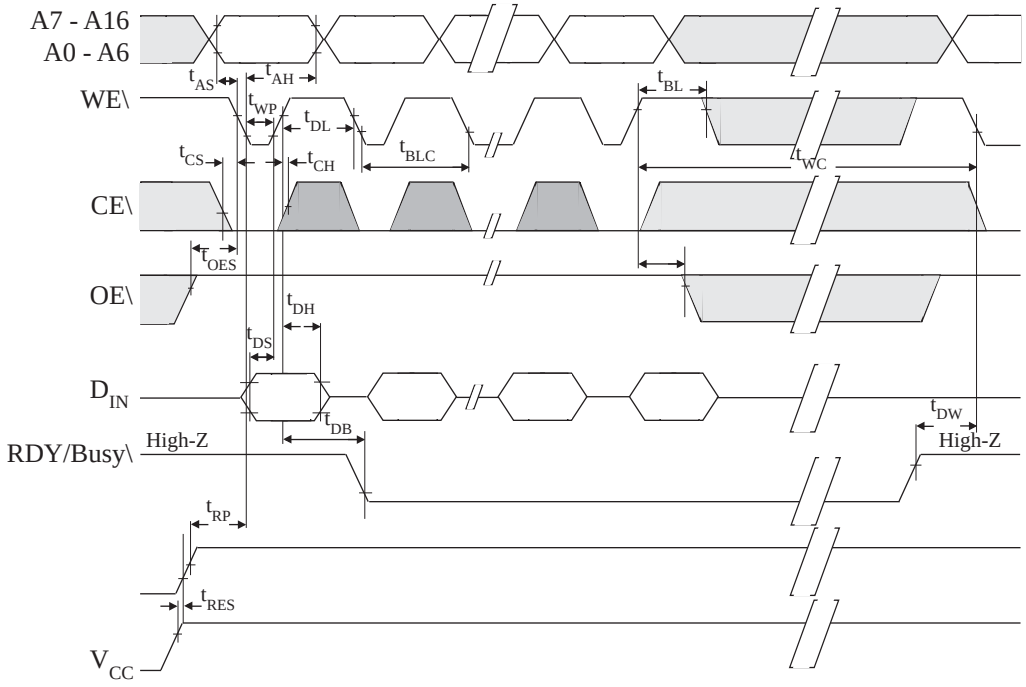
TOGGLE BIT WAVEFORM



In transition from HI to LOW or LOW to HI.

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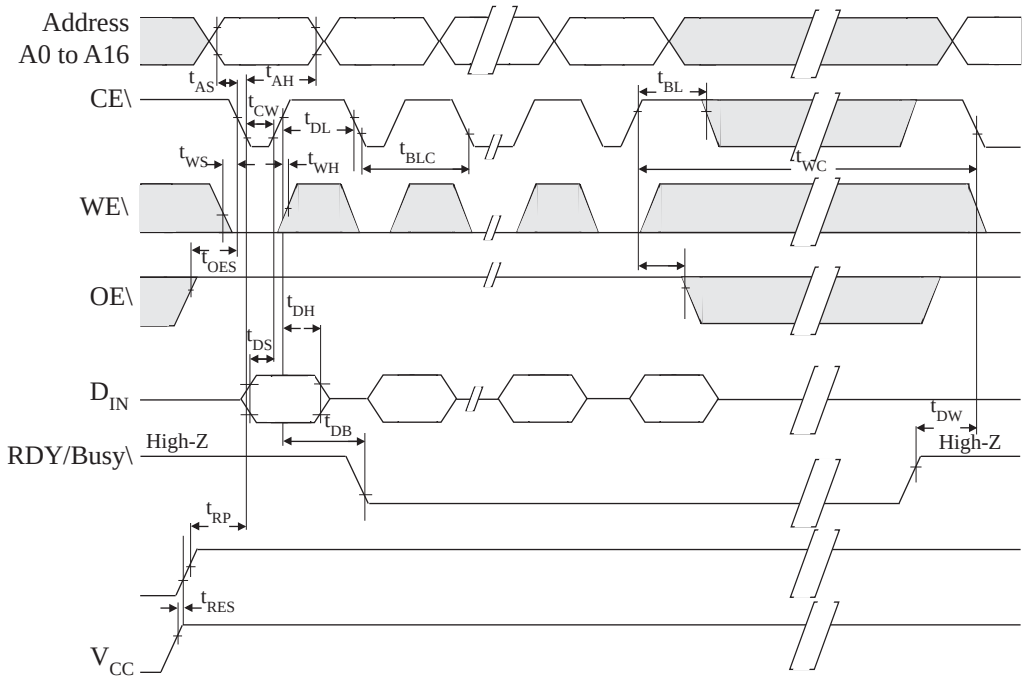
PAGE WRITE TIMING WAVEFORM
(WE\ CONTROLLED)



In transition from HI to LOW or LOW to HI.

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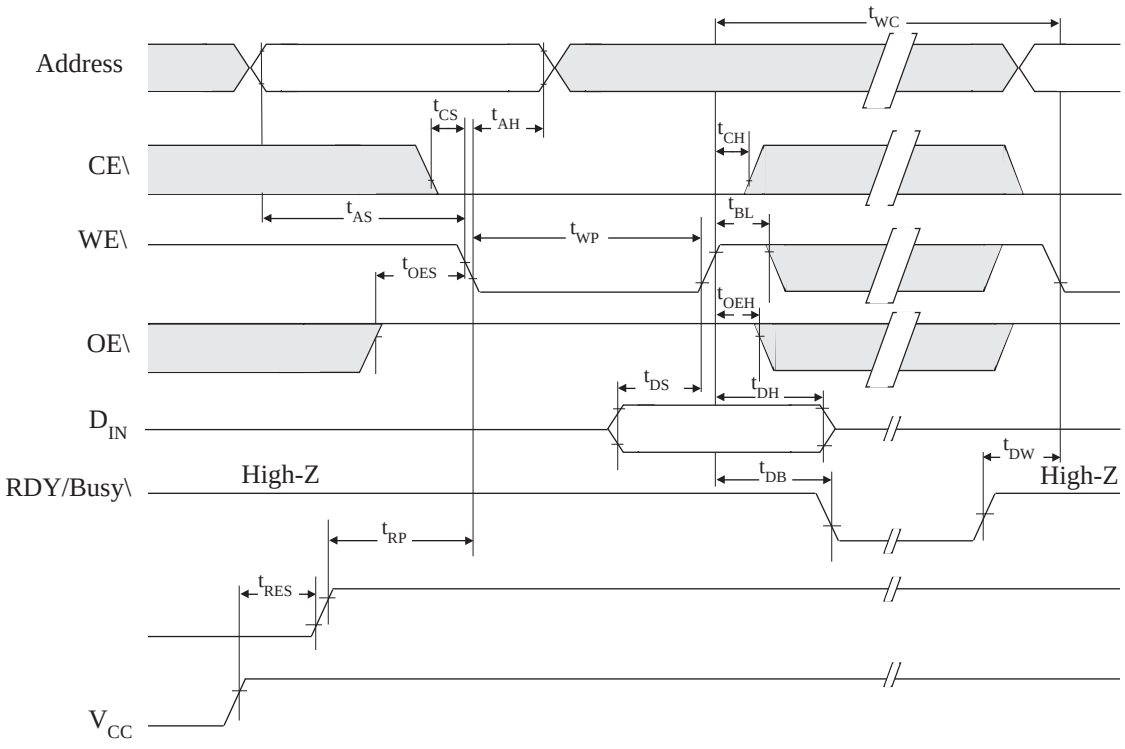
PAGE WRITE TIMING WAVEFORM
(CE\ CONTROLLED)



In transition from HI to LOW or LOW to HI.

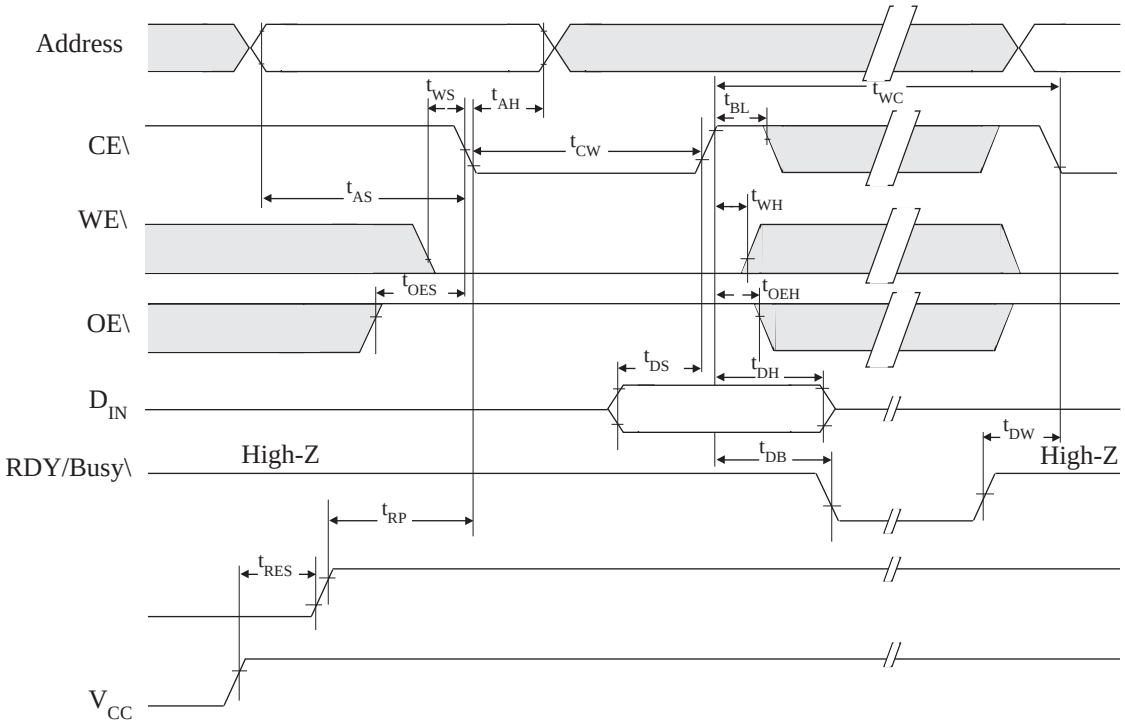
Micross Components reserves the right to change products or specifications without notice.

BYTE WRITE TIMING WAVEFORM
(WE\ CONTROLLED)



In transition from HI to LOW or LOW to HI.

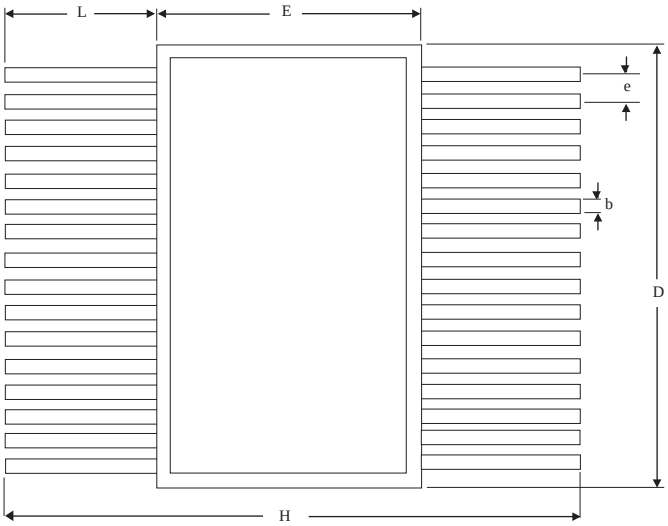
BYTE WRITE TIMING WAVEFORM
(CE\ CONTROLLED)



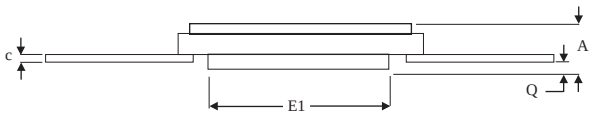
In transition from HI to LOW or LOW to HI.

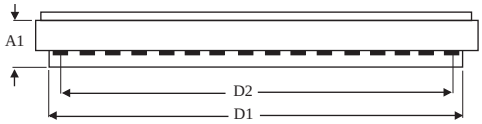
MECHANICAL DEFINITIONS*

Micross Case #305 (Package Designator SF)
SMD # 5962-38267, Case Outline N



Top View



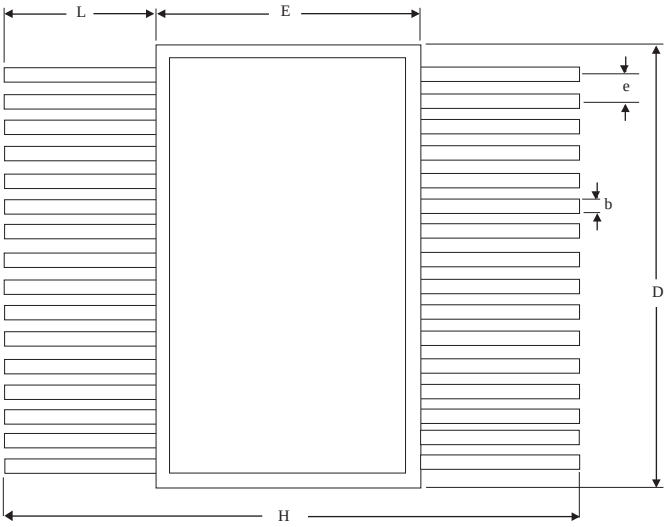


SYMBOL	SMD SPECIFICATIONS	
	MIN	MAX
A	0.125	0.150
A1	0.090	0.110
b	0.015	0.019
c	0.003	0.007
D	0.810	0.830
D1	0.775	0.785
D2	0.745	0.755
E	0.425	0.445
E1	0.290	0.310
e	0.045	0.055
H	1.000	1.100
L	0.290	0.310
Q	0.026	0.037

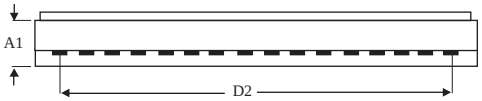
All measurements are in inches.

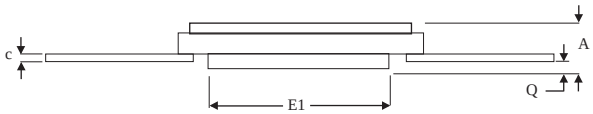
MECHANICAL DEFINITIONS*

Micross Case #306 (Package Designator F)
SMD # 5962-38267, Case Outline M



Top View





SYMBOL	SMD SPECIFICATIONS	
	MIN	MAX
A	0.097	0.123
A1	0.090	0.110
b	0.015	0.019
c	0.003	0.007
D	0.810	0.830
D2	0.745	0.755
E	0.425	0.445
E1	0.330	0.356
e	0.045	0.055
H	1.000	1.100
L	0.290	0.310
Q	0.026	0.037

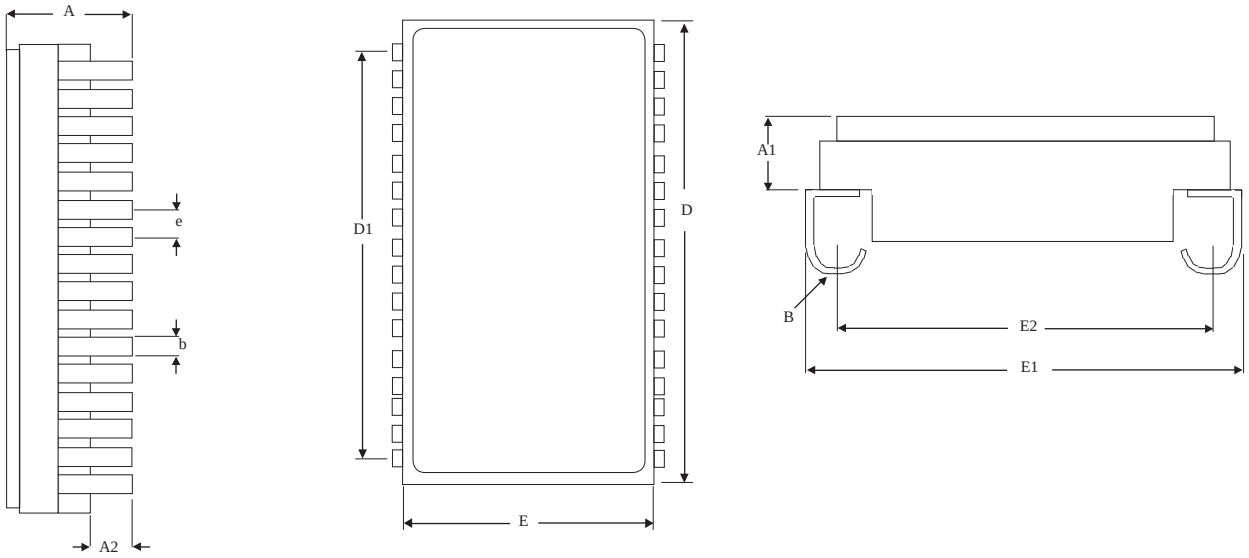
NOTE: *All drawings are per the SMD. Micross' package dimensional limits may differ, but they will be within the SMD limits.*

All measurements are in inches.

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MECHANICAL DEFINITIONS*

Micross Case #508 (Package Designator DCJ)



SYMBOL	MICROSS PACKAGE SPECIFICATIONS	
	MIN	MAX
A	0.132	0.142
A1	0.076	0.086
A2	0.018	0.028
B	0.018	0.032
b	0.015	0.019
D	0.816	0.834
D1	0.745	0.755
E	0.430	0.440
E1	0.465	0.485
E2	0.415	0.425
e	0.045	0.055

All measurements are in inches.

Micross Components reserves the right to change products or specifications without notice.

ORDERING INFORMATION

EXAMPLE: AS58C1001SF-15/IT

Device Number	Package Type	Speed ns	Process
AS58C1001	SF	-15	/*
AS58C1001	SF	-20	/*
AS58C1001	SF	-25	/*

EXAMPLE: AS58C1001F-25/883C

Device Number	Package Type	Speed ns	Process
AS58C1001	F	-15	/*
AS58C1001	F	-20	/*
AS58C1001	F	-25	/*

EXAMPLE: AS58C1001DCJ-20/IT

Device Number	Package Type	Speed ns	Process
AS58C1001	DCJ	-15	/*
AS58C1001	DCJ	-20	/*
AS58C1001	DCJ	-25	/*

*AVAILABLE PROCESSES

IT = Industrial Temperature Range -40°C to +85°C
XT = Extended Temperature Range -55°C to +125°C
883C = Full Military Processing -55°C to +125°C

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MICROSS TO DSCC PART NUMBER

Package Designator F

Micross Part #	SMD Part#
AS58C1001F-25/883C	5962-3826716QMA
AS58C1001F-20/883C	5962-3826717QMA
AS58C1001F-15/883C	5962-3826718QMA

Package Designator SF

Micross Part #	SMD Part#
AS58C1001SF-25/883C	5962-3826716QNA
AS58C1001SF-20/883C	5962-3826717QNA
AS58C1001SF-15/883C	5962-3826718QNA

Package Designators DCJ not currenly available on the SMD

DOCUMENT TITLE
128K x 8 EEPROM

Rev #	History	Release Date	Status
5.5	Removed ECA Package	December 2008	Release
5.6	Removed 5962 references	November 2009	Release
5.7	Removed DG drawing & references	December 2009	Release
5.8	Added Micross Information	January 2010	Release
5.9	Updated Military Specifications and note on page 1	November 2010	Release

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